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| --- | --- | --- | --- |
| QUALIFICATION RESULTS | | | |
| Test | Conditions | Sample Size | Results |
| Highly Accelerated Stress Test (HAST)\* | JEDEC*JESD22-A110* | **308** | **Pass** |
| Temperature Cycle (TC)\* | JEDEC*JESD22-A104* | **308** | **Pass** |
| Autoclave (AC)\* | JEDEC *JESD22-A102* | **308** | **Pass** |
| High Temperature Storage Life (HTSL) | JEDEC *JESD22-A103* | **154** | **Pass** |
| Solder Heat Resistance  (SHR)\* | *ADI-0049* | **63** | **Pass** |
| Electrostatic Discharge  *Field-Induced Charged Device Model* | JEDEC *JESD22-C101* | **3/voltage** | **Pass 500V** |

\*Preconditioned per JEDEC/IPC J-STD-020